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1-Mbit (128 K × 8) Static RAM

Features

- Pin- and function-compatible with CY7C1019B
- High speed

 □ t_{AA} = 10 ns
- Low active power
 □ I_{CC} = 80 mA @ 10 ns
- Low CMOS standby power
 □ I_{SB2} = 3 mA
- 2.0 V Data retention
- Automatic power-down when deselected
- CMOS for optimum speed/power
- Center power/ground pinout
- Easy memory expansion with $\overline{\text{CE}}$ and $\overline{\text{OE}}$ options
- Functionally equivalent to CY7C1019B
- Available in Pb-free 32-pin 400-Mil wide Molded SOJ and 32-pin TSOP II packages

Functional Description

The CY7C1019D ^[1] is a high-performance CMOS static RAM organized as 131,072 words by 8 bits. Easy memory expansion is provided by an active LOW Chip Enable (CE), an active LOW Output Enable (OE), and tri-state drivers. This device has an automatic power-down feature that significantly reduces power consumption when deselected. The eight input and output pins (IO₀ through IO₇) are placed in a high-impedance state when:

- Deselected (CE HIGH)
- Outputs are disabled (OE HIGH)
- When the write operation is active (\overline{CE} LOW, and \overline{WE} LOW).

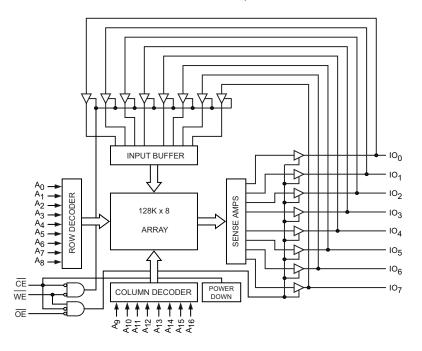
Write to the device by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. Data on the eight IO pins $(IO_0$ through $IO_7)$ is then written into the location specified on the address pins $(A_0$ through $A_{16})$.

Read from the device by taking Chip Enable (\overline{CE}) and Output Enable (\overline{OE}) LOW while forcing Write Enable (\overline{WE}) HIGH. Under these conditions, the contents of the memory location specified by the address pins appears on the IO pins.

The CY7C1019D device is suitable for interfacing with processors that have TTL I/P levels. It is not suitable for processors that require CMOS I/P levels. Please see Electrical Characteristics on page 4 for more details and suggested alternatives.

For a complete list of related documentation, click here.

Logic Block Diagram



Note

1. For guidelines on SRAM system design, please refer to the 'System Design Guidelines' Cypress application note, available on the internet at www.cypress.com.





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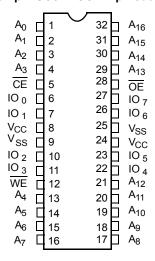
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Pin Configuration

Figure 1. 32-pin SOJ / TSOP II pinout (Top View)



Selection Guide

Description	-10 (Industrial)	Unit
Maximum Access Time	10	ns
Maximum Operating Current	80	mA
Maximum Standby Current	3	mA



Maximum Ratings

Exceeding the maximum ratings may impair the useful life of the device. These user guidelines are not tested. Storage Temperature-65 °C to +150 °C Ambient Temperature with Power Applied–55 °C to +125 °C Supply Voltage on V $_{CC}$ to Relative GND $^{[2]}$ –0.5 V to +6.0 V

DC Input Voltage [2]	0.5 V to V _{CC} + 0.5 V
Current into Outputs (LOW)	20 mA
Static Discharge Voltage (per MIL-STD-883, Method 3015)	> 2001 V
Latch-up Current	> 200 mA

Operating Range

Range	Ambient Temperature	V _{CC}	Speed
Industrial	–40 °C to +85 °C	$5~V\pm0.5~V$	10 ns

Electrical Characteristics

Over the Operating Range

Downston	Decemention	Took Conditions		-10 (Inc	dustrial)	11::::4
Parameter	Description	Test Conditions		Min	Max	Unit
V _{OH}	Output HIGH Voltage I _{OH} = -4.0 mA			2.4	_	V
		I _{OH} = -0.1 mA		-	3.4 ^[3]	
V_{OL}	Output LOW Voltage	I _{OL} = 8.0 mA		-	0.4	V
V _{IH}	Input HIGH Voltage			2.2	V _{CC} + 0.5	V
V_{IL}	Input LOW Voltage [2]					V
I _{IX}	Input Leakage Current	$GND \le V_I \le V_{CC}$		– 1	+1	μΑ
I _{OZ}	Output Leakage Current	$GND \le V_1 \le V_{CC}$, Output Disabled		– 1	+1	μΑ
I _{CC}	V _{CC} Operating Supply Current	$V_{CC} = Max$, $I_{OUT} = 0$ mA, $f = f_{max} = 1/t_{RC}$	100 MHz	-	80	mA
			83 MHz	-	72	mA
			66 MHz	-	58	mA
			40 MHz	-	37	mA
I _{SB1}	Automatic CE Power-Down Current – TTL Inputs	Max V_{CC} , $\overline{CE} \ge V_{IH}$, $V_{IN} \ge V_{IH}$ or $V_{IN} \le V_{IL}$, $f = f_{max}$		_	10	mA
I _{SB2}	Automatic CE Power-Down Current – CMOS Inputs	$\begin{array}{l} \text{Max V}_{CC}, \ \overline{\text{CE}} \geq \text{V}_{CC} - 0.3 \text{ V}, \\ \text{V}_{\text{IN}} \geq \text{V}_{CC} - 0.3 \text{ V}, \text{ or V}_{\text{IN}} \leq 0.3 \text{ V}, \text{ f} = \end{array}$	0	-	3	mA

Note

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V_{IL} (min) = -2.0 V and V_{IH}(max) = V_{CC} + 1 V for pulse durations of less than 5 ns.
 Please note that the maximum V_{OH} limit does not exceed minimum CMOS VIH of 3.5V. If you are interfacing this SRAM with 5 V legacy processors that require a minimum V_{IH} of 3.5 V, please refer to Application Note AN6081 for technical details and options you may consider.



Capacitance

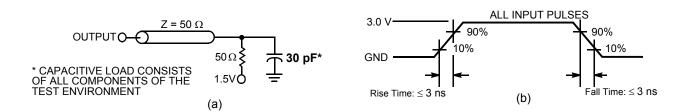
Parameter [4] Description Test Condition		Test Conditions	Max	Unit
C _{IN}	Input capacitance	$T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz}, V_{CC} = 5.0 \text{V}$	6	pF
C _{OUT}	Output capacitance		8	pF

Thermal Resistance

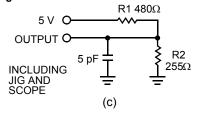
Parameter [4]	Description	Test Conditions	400-Mil Wide SOJ	TSOP II	Unit
Θ_{JA}		Still Air, soldered on a 3 × 4.5 inch, four-layer printed circuit board	56.29	62.22	°C/W
$\Theta_{\sf JC}$	Thermal resistance (junction to case)		38.14	21.43	°C/W

AC Test Loads and Waveforms

Figure 2. AC Test Loads and Waveforms [5]



High Z characteristics:



Notes

- 4. Tested initially and after any design or process changes that may affect these parameters.
- 5. AC characteristics (except High Z) are tested using the load conditions shown in Figure 2 (a). High Z characteristics are tested for all speeds using the test load shown in Figure 2 (c).

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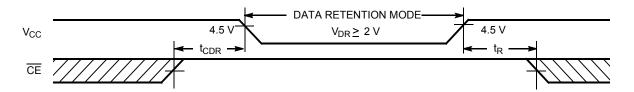
Data Retention Characteristics

Over the Operating Range

Parameter	Description	Conditions	Min	Max	Unit
V_{DR}	V _{CC} for Data Retention		2.0	-	V
I _{CCDR}	Data Retention Current	$V_{CC} = V_{DR} = 2.0 \text{ V}, \overline{CE} \ge V_{CC} - 0.3 \text{ V},$ $V_{IN} \ge V_{CC} - 0.3 \text{ V or } V_{IN} \le 0.3 \text{ V}$	_	3	mA
t _{CDR} ^[6]	Chip Deselect to Data Retention Time		0	_	ns
t _R ^[7]	Operation Recovery Time		t _{RC}	_	ns

Data Retention Waveform

Figure 3. Data Retention Waveform



 ^{6.} Tested initially and after any design or process changes that may affect these parameters.
 7. Full device operation requires linear V_{CC} ramp from V_{DR} to V_{CC(min)} ≥ 50 μs or stable at V_{CC(min)} ≥ 50 μs.



Switching Characteristics

Over the Operating Range

Parameter [8]	Description	-10 (Inc	-10 (Industrial)	
Parameter [9]	Description	Min	Max	Unit
Read Cycle			•	
t _{power} [9]	V _{CC} (typical) to the first access	100	_	μS
t _{RC}	Read Cycle Time	10	_	ns
t _{AA}	Address to Data Valid	_	10	ns
t _{OHA}	Data Hold from Address Change	3	_	ns
t _{ACE}	CE LOW to Data Valid	_	10	ns
t _{DOE}	OE LOW to Data Valid	_	5	ns
t _{LZOE}	OE LOW to Low Z	0	_	ns
t _{HZOE}	OE HIGH to High Z [10, 11]	_	5	ns
t _{LZCE}	CE LOW to Low Z [11]	3	_	ns
t _{HZCE}	CE HIGH to High Z [10, 11]	_	5	ns
t _{PU} [12]	CE LOW to Power-Up	0	_	ns
t _{PD} [12]	CE HIGH to Power-Down	_	10	ns
Write Cycle [13	, 14]	·		
t _{WC}	Write Cycle Time	10	_	ns
t _{SCE}	CE LOW to Write End	7	_	ns
t _{AW}	Address Set-Up to Write End	7	_	ns
t _{HA}	Address Hold from Write End	0	_	ns
t _{SA}	Address Set-Up to Write Start	0	_	ns
t _{PWE}	WE Pulse Width	7	_	ns
t _{SD}	Data Set-Up to Write End		-	ns
t _{HD}	Data Hold from Write End	0	-	ns
t _{LZWE}	WE HIGH to Low Z [11]	3	_	ns
t _{HZWE}	WE LOW to High Z [10, 11]	_	5	ns

- 8. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V, and output loading of the specified I_{QL}/I_{QH} and 30-pF load capacitance.
- 10. t_{HZOE}, t_{HZOE}, and t_{HZWE} are specified with a load capacitance of 5 pF as in (c) of Figure 2 on page 5. Transition is measured when the outputs enter a high impedance state.

 11. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZOE}, t_{HZOE} is less than t_{LZOE}, and t_{HZWE} is less than t_{LZOE} for any given device.

 12. This parameter is guaranteed by design and is not tested.

- The internal write time of the memory is defined by the overlap of CE LOW and WE LOW. CE and WE must be LOW to initiate a write, and the transition of any of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.
 The minimum write cycle time for Write Cycle no. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.



Switching Waveforms

Figure 4. Read Cycle No. 1 (Address Transition Controlled) [15, 16]

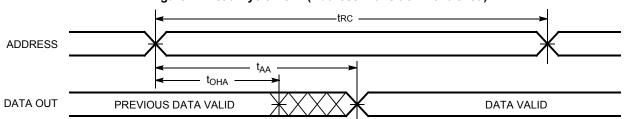
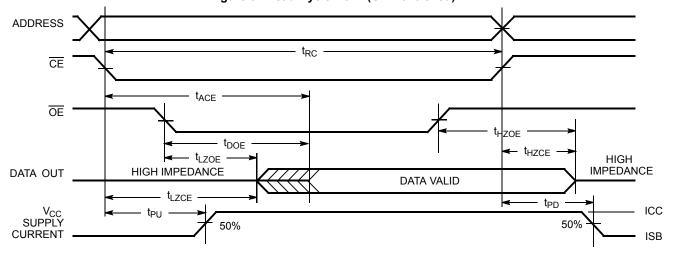


Figure 5. Read Cycle No. 2 (OE Controlled) [16, 17]



^{15. &}lt;u>Device</u> is continuously selected. OE, CE = V_{IL}.

16. WE is HIGH for Read cycle.

17. Address valid prior to or coincident with CE transition LOW.



Switching Waveforms (continued)

Figure 6. Write Cycle No. 1 (CE Controlled) [18, 19]

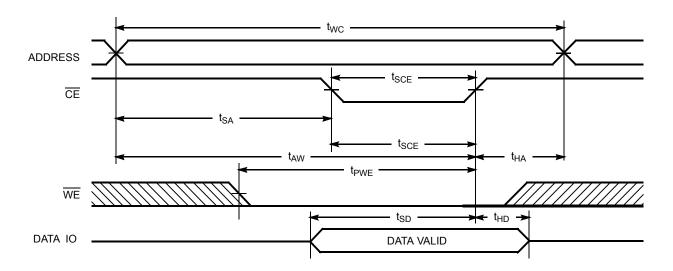
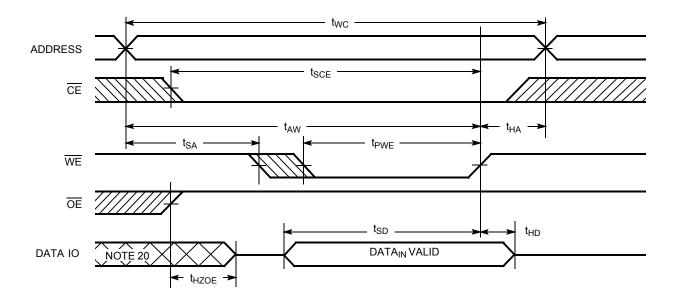


Figure 7. Write Cycle No. 2 (WE Controlled, OE HIGH During Write) [18, 19]



^{18.} Data IO is high impedance if $\overline{OE} = \underline{V_{IH}}$.

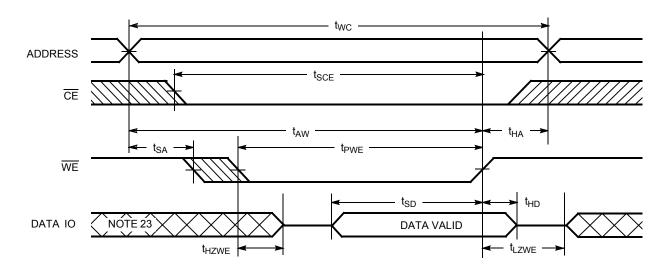
19. If \overline{CE} goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.

20. During this period the IOs are in the output state and input signals should not be applied.



Switching Waveforms (continued)

Figure 8. Write Cycle No. 3 ($\overline{\text{WE}}$ Controlled, $\overline{\text{OE}}$ LOW) [21, 22]



^{21.} The minimum write cycle time for <u>Write</u> Cycle no. 3 (WE Controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.

22. If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.

23. During this period the IOs are in the output state and input signals should not be applied.



Truth Table

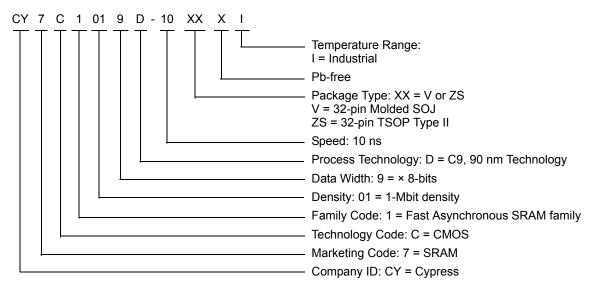
CE	OE	WE	IO ₀ -IO ₇	Mode	Power
Н	Х	Х	High Z	Power-Down	Standby (I _{SB})
L	L	Н	Data Out	Read	Active (I _{CC})
L	Х	L	Data In	Write	Active (I _{CC})
L	Н	Н	High Z	Selected, Outputs Disabled	Active (I _{CC})

Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
10	CY7C1019D-10VXI	51-85033	32-pin SOJ (400 Mils) Pb-free	Industrial
	CY7C1019D-10ZSXI	51-85095	32-pin TSOP (Type II) Pb-free	

Please contact your local Cypress sales representative for availability of these parts.

Ordering Code Definitions

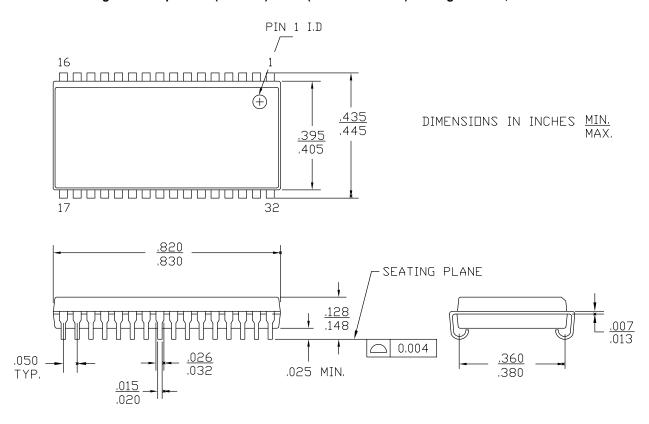


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Package Diagrams

Figure 9. 32-pin SOJ (400 Mils) V32.4 (Molded SOJ V33) Package Outline, 51-85033

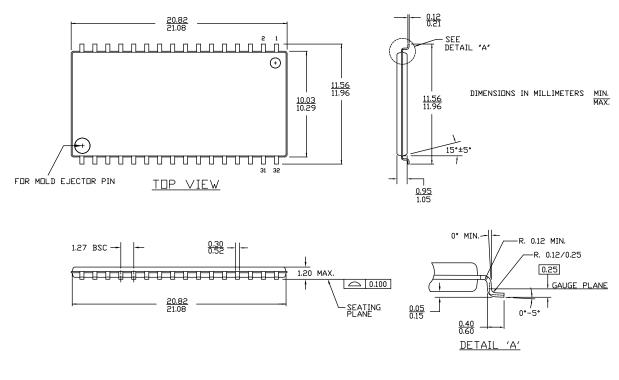


51-85033 *E



Package Diagrams (continued)

Figure 10. 32-pin TSOP II (20.95 × 11.76 × 1.0 mm) ZS32 Package Outline, 51-85095





Acronyms

Acronym	Description		
CE	Chip Enable		
CMOS	Complementary Metal Oxide Semiconductor		
I/O	Input/Output		
OE	Output Enable		
SOJ	Small Outline J-lead		
SRAM	Static Random Access Memory		
TSOP	Thin Small Outline Package		
TTL	Transistor-Transistor Logic		
WE	Write Enable		

Document Conventions

Units of Measure

Symbol	Unit of Measure		
°C	degree Celsius		
MHz	megahertz		
μΑ	microampere		
μs	microsecond		
mA	milliampere		
ms	millisecond		
mm	millimeter		
ns	nanosecond		
Ω	ohm		
%	percent		
pF	picofarad		
V	volt		
W	watt		



Document History Page

Document Title: CY7C1019D, 1-Mbit (128 K × 8) Static RAM Document Number: 38-05464					
Rev.	ECN No.	Issue Date	Orig. of Change	Description of Change	
**	201560	See ECN	SWI	Advance Information data sheet for C9 IPP	
*A	233715	See ECN	RKF	DC parameters are modified as per EROS (Spec # 01-2165) Pb-free offering in the Ordering Information	
*B	262950	See ECN	RKF	Added T _{power} Spec in Switching Characteristics table Added Data Retention Characteristics table and waveforms Shaded Ordering Information	
*C	307598	See ECN	RKF	Reduced Speed bins to -10 and -12 ns	
*D	520647	See ECN	VKN	Changed status from Preliminary to Final. Removed Commercial Temperature Range related information in all instances across the document. Removed 12 ns speed bin related information in all instances across the document. Updated Electrical Characteristics: Added values of I _{CC} parameter corresponding to Test Conditions 83 MHz, 66 MHz and 40 MHz. Updated Note 2 (Replaced "V _{CC} + 2 V" with "V _{CC} + 1 V"). Updated Thermal Resistance. Updated Ordering Information.	
*E	802877	See ECN	VKN	Updated Electrical Characteristics: Changed maximum value of I _{CC} parameter from 60 mA to 80 mA corresponding to Test Condition 100 MHz. Changed maximum value of I _{CC} parameter from 55 mA to 72 mA corresponding to Test Condition 83 MHz. Changed maximum value of I _{CC} parameter from 45 mA to 58 mA corresponding to Test Condition 66 MHz. Changed maximum value of I _{CC} parameter from 30 mA to 37 mA corresponding to Test Condition 40 MHz.	
*F	3110052	12/14/2010	AJU	Added Ordering Code Definitions. Updated Package Diagrams.	
*G	3245896	05/02/2011	PRAS	Updated Package Diagrams. Added Acronyms and Units of Measure. Updated to new template.	
*H	4038234	06/24/2013	MEMJ	Updated Functional Description. Updated Electrical Characteristics: Added one more Test Condition " $I_{OH} = -0.1$ mA" for V_{OH} parameter and added maximum value corresponding to that Test Condition. Added Note 3 and referred the same note in maximum value for V_{OH} parameter corresponding to Test Condition " $I_{OH} = -0.1$ mA". Updated to new template.	
*	4385827	05/21/2014	MEMJ	Updated Package Diagrams: spec 51-85033 – Changed revision from *D to *E. Completing Sunset Review.	
*J	4579569	11/26/2014	MEMJ	Updated Functional Description: Added "For a complete list of related documentation, click here." at the end.	
*K	4795495	06/12/2015	NILE	Updated Package Diagrams: spec 51-85095 – Changed revision from *B to *D. Updated to new template.	



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